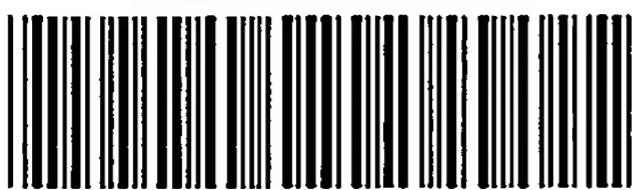


Search Notes



Application/Control No.

10/645.352

Examiner

Philip H. Leung

**Applicant(s)/Patent under
Reexamination**

RYPAN, ZENON

Art Unit

3742

SEARCHED

INTERFERENCE SEARCHED

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)